

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/685,380	<b>Applicant(s)/Patent under Reexamination</b> MAEKAWA, SHINJI
	<b>Examiner</b> David Goodwin	<b>Art Unit</b> 2818

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
see attached		9/13/2007	DJG